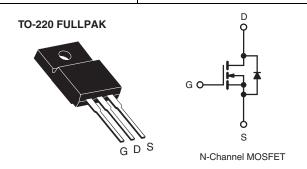


Vishay Siliconix

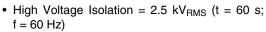
### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	900			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	8.0		
Q <sub>g</sub> (Max.) (nC)	38			
Q <sub>gs</sub> (nC)	4.7			
Q <sub>gd</sub> (nC)	21			
Configuration	Single			



### **FEATURES**

· Isolated Package







- · Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION		
Package	TO-220 FULLPAK	
Lead (Pb)-free	IRFIBF20GPbF	
Lead (FD)-liee	SiHFIBF20G-E3	
SnPb	IRFIBF20G	
JIIF D	SiHFIBF20G	

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		$V_{DS}$	900	V	
Gate-Source Voltage	$V_{GS}$	± 20	1 v		
Continuous Drain Current	$V_{GS}$ at 10 V $T_C = 25 ^{\circ}C$	1-	1.2	А	
	$V_{GS}$ at 10 V $T_C = 100 ^{\circ}C$	I <sub>D</sub>	0.79		
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	4.8			
Linear Derating Factor			0.24	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	150	mJ		
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	1.2	Α		
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	3.0	mJ		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	$P_D$	30	W	
Peak Diode Recovery dV/dtc	dV/dt	1.5	V/ns		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	6-32 OF IVIS SCIEW		1.1	N · m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 196 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 1.2 A (see fig. 12).
- c.  $I_{SD} \le 1.7$  A,  $dI/dt \le 70$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFIBF20G, SiHFIBF20G

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	4.1	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static		·					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	900	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	1.1	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V		-	± 100	nA
7 0		V <sub>DS</sub> =	V <sub>DS</sub> = 900 V, V <sub>GS</sub> = 0 V		-	100	,
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 720 \	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 0.72 A <sup>b</sup>	-	-	8.0	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 0.72 A <sup>b</sup>		-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V,		-	490	-	
Output Capacitance	C <sub>oss</sub>	1 .	$V_{DS} = 25 V$ ,		55	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	18	-	pF
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Qg		I <sub>D</sub> = 1.7 A, V <sub>DS</sub> = 360 V, see fig. 6 and 13 <sup>b</sup>	-	-	38	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V		-	-	4.7	
Gate-Drain Charge	$Q_{gd}$	1		-	-	21	
Turn-On Delay Time	t <sub>d(on)</sub>		'		8.0	-	- ns
Rise Time	t <sub>r</sub>	$V_{DD} = 450 \text{ V, } I_D = 1.7 \text{ A,}$ $R_G = 18 \ \Omega, R_D = 280 \ \Omega,$ see fig. $10^b$		-	21	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	56	-	
Fall Time	t <sub>f</sub>			-	32	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	1.2	- A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	4.8	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C}, \ I_S = 1.2  \text{A}, \ V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 1.7 A, dl/dt = 100 A/μs <sup>b</sup>		-	350	530	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			-	0.85	1.3	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and I				_D)	

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.





### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

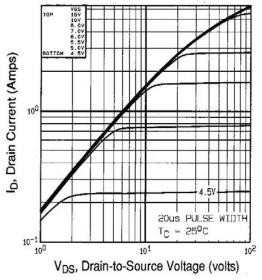


Fig. 1 - Typical Output Characteristics,  $T_C = 25~^{\circ}C$ 

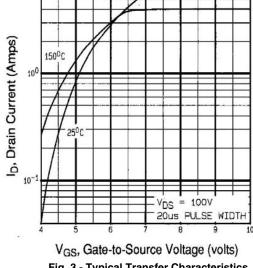


Fig. 3 - Typical Transfer Characteristics

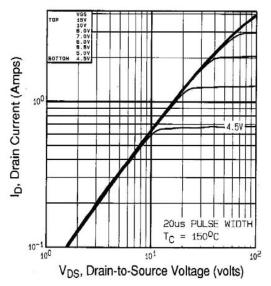


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

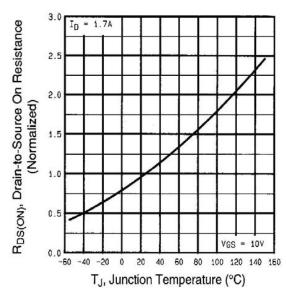


Fig. 4 - Normalized On-Resistance vs. Temperature

# IRFIBF20G, SiHFIBF20G

## Vishay Siliconix



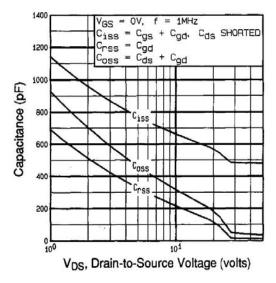


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

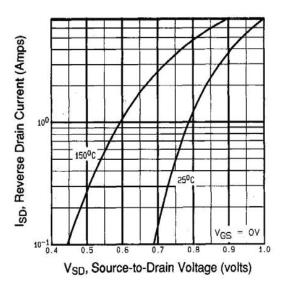


Fig. 7 - Typical Source-Drain Diode Forward Voltage

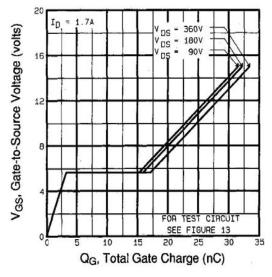


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

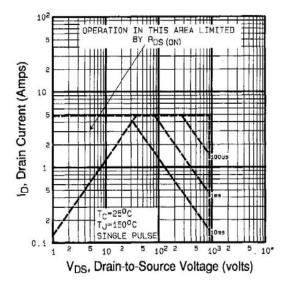


Fig. 8 - Maximum Safe Operating Area



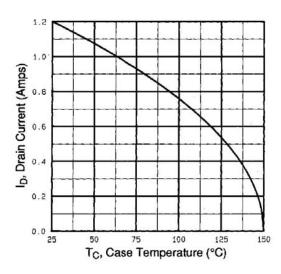


Fig. 9 - Maximum Drain Current vs. Case Temperature

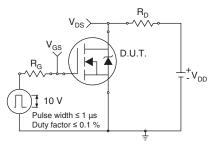


Fig. 10a - Switching Time Test Circuit

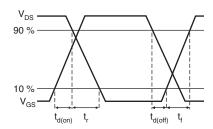


Fig. 10b - Switching Time Waveforms

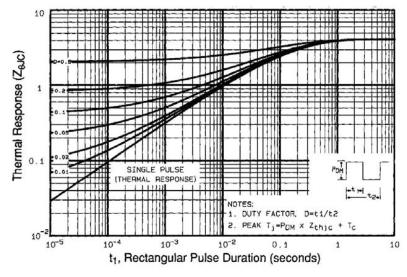


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

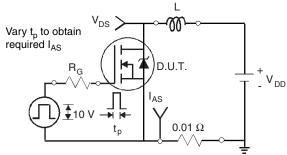


Fig. 12a - Unclamped Inductive Test Circuit

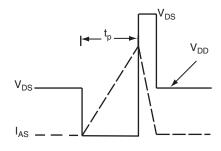


Fig. 12b - Unclamped Inductive Waveforms

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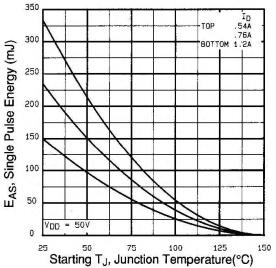


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

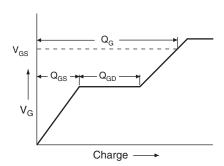


Fig. 13a - Basic Gate Charge Waveform

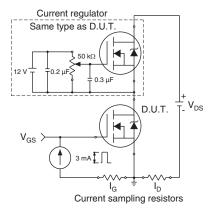
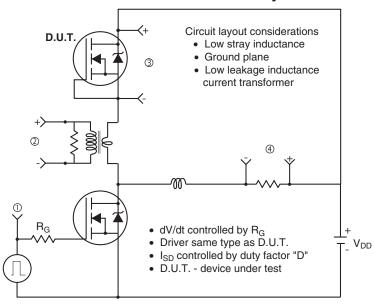


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit



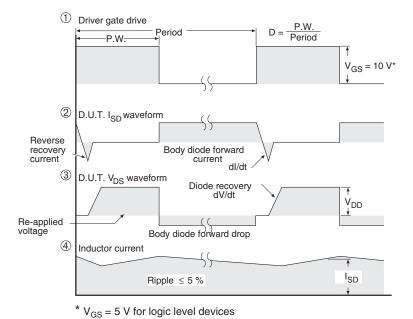


Fig. 14 - For N-Channel

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